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1 Electrical ratings

Table 2. Absolute maximum ratings

		Va		
Symbol	Parameter	D ² PAK TO-220 TO-247	TO-220FP	Unit
V_{GS}	Gate-source voltage	± 2	25	V
I _D	Drain current (continuous) at T _C = 25 °C 30		30 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	19	19 ⁽¹⁾	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	120	120 (1)	Α
P _{TOT}	Total dissipation at T _C = 25 °C	190	35	W
dv/dt (2)	Peak diode recovery voltage slope	1	5	V/ns
dv/dt (3)	MOSFET dv/dt ruggedness	5	0	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; Tc = 25 °C)		2500	٧
T _{stg}	Storage temperature	- 55 to 150		°C
T _j	Max. operating junction temperature	15	50	°C

^{1.} Limited by maximum junction temperature.

Table 3. Thermal data

Symbol Parameter		Value				
Symbol	Farameter -	D ² PAK	TO-220FP	TO-220	TO-247	Unit
R _{thj-case}	Thermal resistance junction- case max	0.66	3.6	0.66		°C/W
R _{thj-pcb}	Thermal resistance junction-pcb max ⁽¹⁾	30				°C/W
R _{thj-amb}	Thermal resistance junction- ambient max		62.5		50	°C/W

^{1. 1.}When mounted on 1inch² FR-4 board, 2 oz Cu.

^{2.} $I_{SD} \leq$ 30 A, di/dt \leq 400 A/ μ s; $V_{Peak} < V_{(BR)DSS}$, $V_{DD=400 \ V}$

 $^{3. \}quad V_{DS} \leq \, 480 \; V$

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T_{jmax})	8	Α
E _{AS}	Single pulse avalanche energy (starting t_j = 25°C, I_d = I_{AR} ; V_{dd} = 50V)	660	mJ

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2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	650			٧
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 650 V V _{DS} = 650 V, T _C =125 °C			1 100	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3	4	5	٧
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 15 A		0.073	0.095	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C ^{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0	-	3000 74 5.8	-	pF pF pF
C ^{o(tr)(1)}	Equivalent capacitance time related	V _{DS} = 0 to 520 V, V _{GS} = 0	-	244	-	pF
C ^{o(er)(2)}	Equivalent capacitance energy related	V _{DS} = 0 to 320 V, V _{GS} = 0	-	70	-	рF
R_{G}	Intrinsic gate resistance	f = 1 MHz open drain	-	2.4	-	Ω
Q_g	Total gate charge	V _{DD} = 520 V, I _D = 15 A,		71		nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V	-	18	-	nC
Q_{gd}	Gate-drain charge	(see Figure 20)		30		nC

^{1.} Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}



^{2.} Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d (v)}	Voltage delay time	V _{DD} = 400 V, I _D = 20 A,		66		ns
t _{r (v)}	Voltage rise time	$R_G = 4.7 \Omega, V_{GS} = 10 V$		9		ns
t _{f (i)}	Current fall time	(see <i>Figure 21</i> and	_	9	-	ns
t _{c(off)}	Crossing time	Figure 24)		13		ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)		-		30 120	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 30 A, V _{GS} = 0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 30 A, di/dt = 100 A/μs V _{DD} = 100 V (see <i>Figure 24</i>)	-	382 6.6 35		ns μC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 30 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see <i>Figure 24</i>)	-	522 10.3 40		ns μC A

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for D²PAK and TO-220

Figure 3. Thermal impedance for D²PAK and TO-220

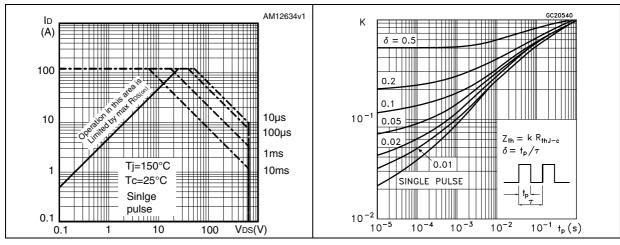


Figure 4. Safe operating area for TO-220FP

Figure 5. Thermal impedance for TO-220FP

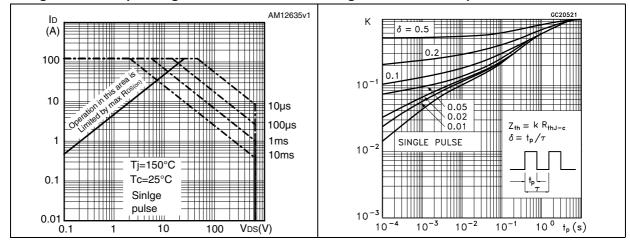


Figure 6. Safe operating area for TO-247

Figure 7. Thermal impedance for TO-247

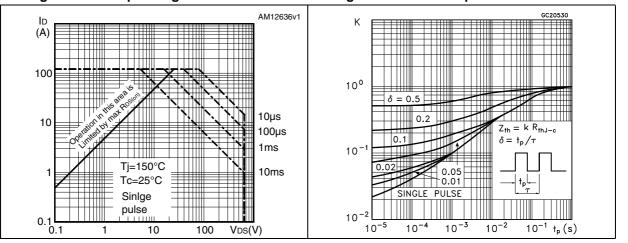




Figure 8. Output characteristics

AM12637v1 ΙD (A) Vgs = 10 V 80 Vgs = 8 V Vgs = 7 V60 40 Vgs = 6 V20 5 10 15 20 25 VDS(V)

Figure 9. Transfer characteristics

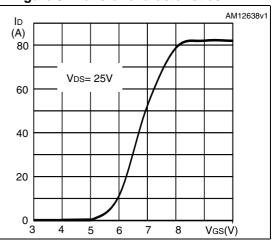
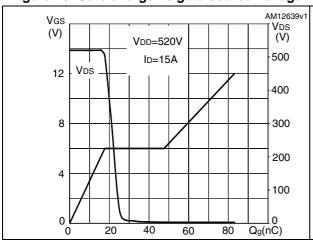


Figure 10. Gate charge vs gate-source voltage

Figure 11. Static drain-source on-resistance



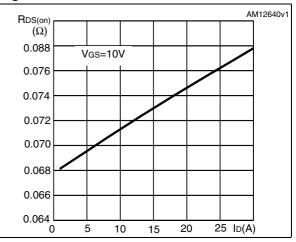
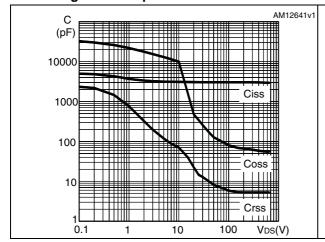


Figure 12. Capacitance variations

Figure 13. Output capacitance stored energy



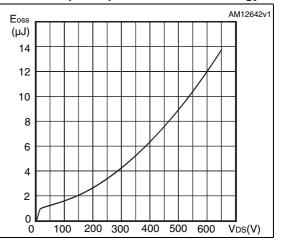


Figure 14. Normalized gate threshold voltage vs temperature

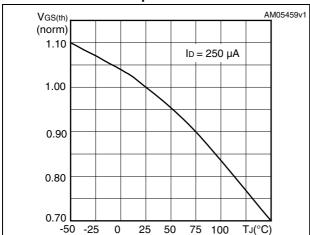


Figure 15. Normalized on-resistance vs temperature

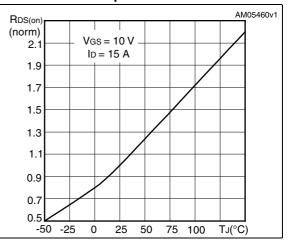
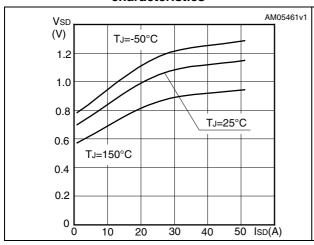


Figure 16. Source-drain diode forward characteristics

Figure 17. Normalized $\ensuremath{V_{DS}}$ vs temperature



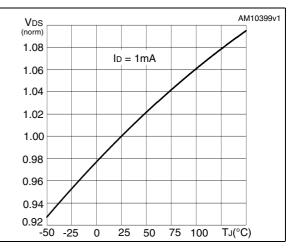
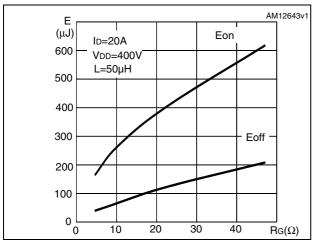


Figure 18. Switching losses vs gate resistance



1. Eon including reverse recovery of a SiC diode.

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3 Test circuits

Figure 19. Switching times test circuit for resistive load

Figure 20. Gate charge test circuit

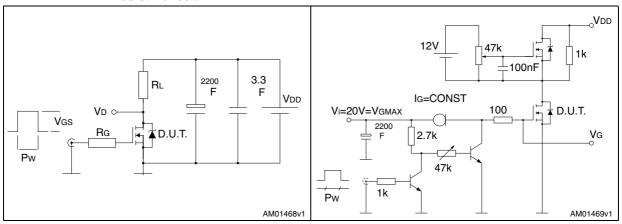


Figure 21. Test circuit for inductive load switching and diode recovery times

Figure 22. Unclamped inductive load test circuit

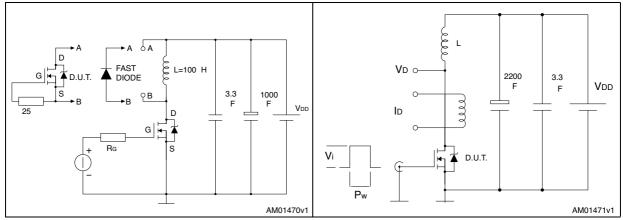
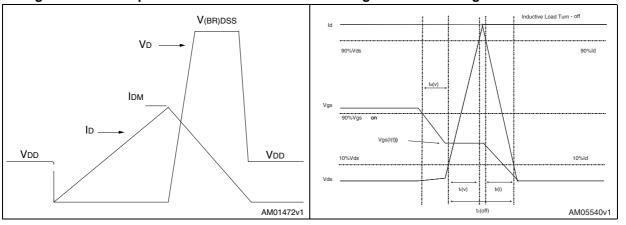


Figure 23. Unclamped inductive waveform

Figure 24. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 9. D²PAK (TO-263) mechanical data

Dim.		mm	
Dilli.	Min.	Тур.	Max.
Α	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
С	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50		
E	10		10.40
E1	8.50		
е		2.54	
e1	4.88		5.28
Н	15		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.4	
V2	0°		8°



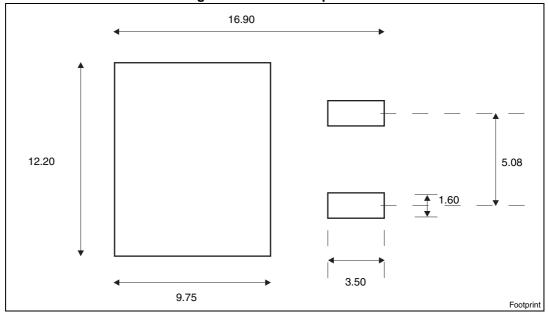
SEATING PLANE
COPLANARITY AT

AUGE PLANE
V2

0079457_T

Figure 25. D²PAK (TO-263) drawing





a. All dimension are in millimeters

Table 10. TO-220FP mechanical data

Table 10: 10 22011 mediamour data					
Dim.		mm			
Diiii.	Min.	Тур.	Max.		
А	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
E	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
Н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		

*B* L6 L2 *L7* L3 Ļ5 F1 L4 F2 -*E* 7012510_Rev_K_B

Figure 27. TO-220FP drawing

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Table 11. TO-220 type A mechanical data

		mm	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

Figure 28. TO-220 type A drawing

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Table 12. TO-247 mechanical data

Table 12. 10 247 mediamedi data					
Dim.		mm.			
Dilli.	Min.	Тур.	Max.		
Α	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
Е	15.45		15.75		
е	5.30	5.45	5.60		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
ØP	3.55		3.65		
ØR	4.50		5.50		
S	5.30	5.50	5.70		

HEAT-SINK PLANE

BACK VIEW 0075325, G

Figure 29. TO-247 drawing

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5 Packaging mechanical data

Table 13. D²PAK (TO-263) tape and reel mechanical data

Таре				Reel		
Dim.	mm		Dim.	mm		
	Min.	Max.	Dim.	Min.	Max.	
A0	10.5	10.7	Α		330	
В0	15.7	15.9	В	1.5		
D	1.5	1.6	С	12.8	13.2	
D1	1.59	1.61	D	20.2		
Е	1.65	1.85	G	24.4	26.4	
F	11.4	11.6	N	100		
K0	4.8	5.0	Т		30.4	
P0	3.9	4.1				
P1	11.9	12.1		Base qty	1000	
P2	1.9	2.1		Bulk qty	1000	
R	50					
Т	0.25	0.35				
W	23.7	24.3				



Figure 30. Tape

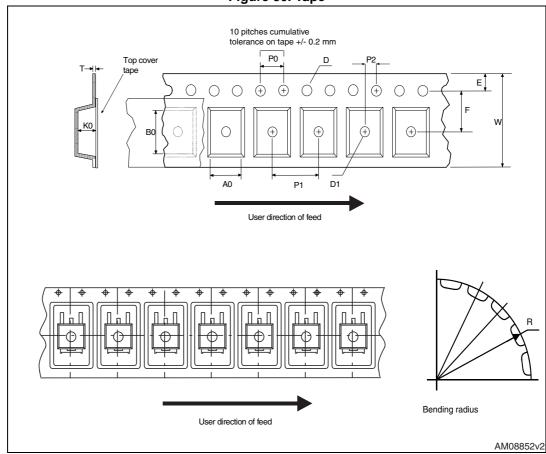
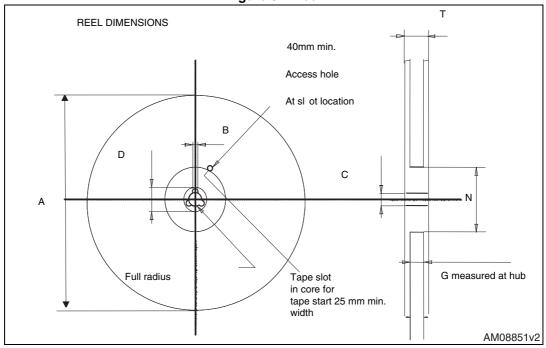


Figure 31. Reel



4

6 Revision history

Table 14. Document revision history

·					
Date	Revision	Changes			
22-Feb-2012	1	First release.			
21-Jun-2012	2	Document status changed from preliminary data to production data. Added Section 2.1: Electrical characteristics (curves).			
05-Mar-2013	3	Added dv/dt value on Table 2: Absolute maximum ratings.			

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